

L Number	Hits	Search Text	DB	Time stamp
16	3203	(250/492.22,492.23,492.2).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 20:56
17	393	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:10
18	9	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:03
20	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and comput\$5 and calculat\$5) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 20:59
21	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:00
22	145	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:04
24	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)) and (comput\$5 or calculat\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:01
23	2	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:01
19	4	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and comput\$5 and calculat\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
25	38	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:12
26	5	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:04

27	5	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
28	4	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
29	0	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
30	4	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:06
32	3	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5) and densit\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:08
33	3	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5) and densit\$4) and current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:08
31	4	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:09
34	227	(charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:11
35	28	((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13

36	26	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13
37	26	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13
38	26	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:14
39	17	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:15
40	17	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:16
41	6	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)) and current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:16
42	2	((((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)) and ((calculat\$5 or control\$5 or determin\$5) near4 dos\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:17

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16	3203	(250/492.22,492.23,492.2).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 20:56
17	393	(charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:10
18	9	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:03
20	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and comput\$5 and calculat\$5) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 20:59
21	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:00
22	145	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:04
24	1	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)) and (comput\$5 or calculat\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:01
23	2	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and dos\$4) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:01
19	4	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 adj project\$5) or scan-project\$5 or scanproject\$4)) and comput\$5 and calculat\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
25	38	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:22
26	5	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:22

27	5	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:22
28	4	(((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
29	0	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim43	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:05
30	4	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:06
32	3	((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5) and densit\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:08
33	3	(((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5) and densit\$4) and current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:08
31	4	((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5) and comput\$5 and calculat\$5) and tim\$4) and correct\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:09
34	227	(charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:11
35	28	((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13

36	26	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13
37	26	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:13
38	26	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:14
39	17	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:15
40	17	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:16
41	6	((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)) and current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:16
42	2	((((((((charged-particle or (charged adj particle) or electron) and pattern\$3 and ((VSB or variable-shap\$4 or (variable adj shap\$4))near (beam or exposure)) and (etch\$4 or writ\$4)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and control\$5) and (mask or reticle)) and pattern\$4) and (overlap\$4 or (over adj lap\$4) or over-lap\$4)) and (rectang\$4 or square)) and ((calculat\$5 or control\$5 or determin\$5) near4 dos\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:21
43	157	((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((250/492.22,492.23,492.2).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:21

44	20	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((250/492.22,492.23,492.2).CCLS.)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:36
45	3	((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((250/492.22,492.23,492.2).CCLS.)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:22
46	3	(((((charged-particle or (charged adj particle) or electron) and pattern\$3 and (VSB or variable-shap\$4 or (variable adj shap\$4)) and (etch\$4 or writ\$4)) and ((250/492.22,492.23,492.2).CCLS.)) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and dos\$4) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:38
47	193	((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:57
48	21	((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:58
49	12	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:58
50	12	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:38
51	12	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5) and control\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:38
52	5	((((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5) and control\$5) and ((comput\$4 or calculat\$5 or determin\$5) with (dos\$4 or amount))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:40
54	3	((((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5) and control\$5) and ((comput\$4 or calculat\$5 or determin\$5) with (dos\$4 or amount))) and tim\$4) and rectangu\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:41

55	3	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5) and control\$5) and ((comput\$4 or calculat\$5 or determin\$5) with (dos\$4 or amount))) and tim\$4) and rectang\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:41
53	5	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)) and project\$5) and control\$5) and ((comput\$4 or calculat\$5 or determin\$5) with (dos\$4 or amount))) and tim\$4	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:45
56	83	((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:57
57	9	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:58
58	9	(((((250/492.22,492.23,492.2).CCLS.) and ((scan\$5 near4 project\$5) or scan-project\$5 or scanproject\$4)) and ((scan\$5 near2 project\$5) or scan-project\$5 or scanproject\$4)) and (VSB or variable-shap\$4 or (variable adj shap\$4))) and (dos\$4 or amount)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/12 21:58